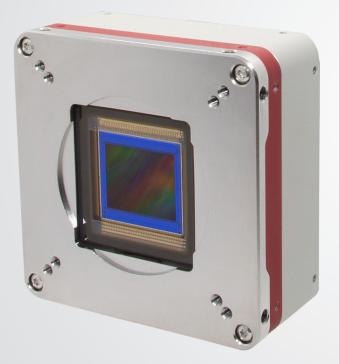
QUARTZ series Q-21A230x/CXP-PA







The QUARTZ Q-21A230x/CXP-PA camera, or in short the Q-21 Performance, brings 5120 by 4096 high quality pixels to the image for real time metrology tasks with a reliable high speed CoaXpress data interface. With 21 megapixel resolution and 228.8 frames per second of measurement speed, the Q-21A230 can greatly improve the precision and throughput of your system. All image information is preserved by Adimec's True Accurate Imaging technique and state of the art global shutter sensor technology.

The Q-21 Performance delivers the best image quality combined with optimal heat management, which makes it the perfect fit for Semiconductor Back End applications.Different operating modes which optimize for maximum dynamic range, high full well or high sensitivity, provide easy system integration with ideal performance under various demanding conditions. The camera offers Adimec Connect & Grab™ allowing engineers to start system development at camera arrival.

Typical application examples: Semiconductor metrology tools; Wafer inspection; Bump inspection; RDL inspection; Digital pathology.

5120 x 4096 at 228.8 fps High full well and low read noise Low frequency flat field correction in bright

Active sensor alignment

Device-to-device repeatability



CXP-12 interface for 4 x 12.5 Gb/s

Target Specifications

	Q-21A230/CXP-PA		
Sensor	GPIXEL GSPRINT4521		
Pixel size	4.5 μm x 4.5 μm		
Resolution	5120 (H) x 4096 (V)		
Electronic shutter	CMOS progressive scan Global Shutter (PLS < 1/20000, angular dependent)		
Video Output	CoaxPress V1.1.1 CXP3/6/10/12 - 2 and 4 lanes configurable		
Image acquisition	Timed, TriggerWidth, SyncControl, TimedTriggerControl		
Output resolution	8 / 10 / 12 bit		
Power input	2 x 24 Vdc nominal, range: 18.5 Vdc to 26 Vdc PoCXP		
Power usage	Typical 16 W @ 24 Vdc full continuous operation at full ROI at maximum framespeed		
Operating sensor temperature	+5°C to +60°C		
Reliability	> 75,000h @ 30°C calculated according to the part stress analysis of MIL-HDBK-217F for ground fixed, uncontrolled environment.		
Weight	600 g +/- 5% excl. lensmount, heatsink and fan		
Lens mount (optional)	4 x M3 at 60mm pitch - 4 x M3 at 54mm pitch - 50mm G7 reference (on request: F, TFL-II, T2, M42)		
Compliance	CE, ROHS		

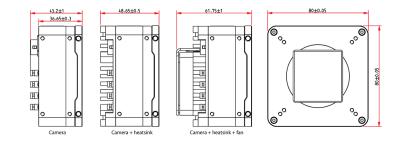
Performance Modes

Mode	Max full well	High full well	Max dynamic range	High sensitivity
Analog gain	1	1.5	2.2	4.8
Full well	33.6 ke-	22.4 ke-	15.3 ke-	7.0 ke-
Dynamic range	66.7 dB	67.3 dB	68.7 dB	66.5 dB
Dark noise	15.5 e-	9.7 e-	5.6 e-	3.3 e-
Typical values @ 12 bit				

Functionality Highlights

Defect pixel correction	\checkmark	\checkmark
Manual and one push white balance	-	\checkmark
Programmable look-up table & gamma curve		\checkmark
Digital fine gain (1x to 32x)		\checkmark
Mirroring		\checkmark
Low Frequency Flat Field Correction (LF FFC)		
Uniformity correction		
Sensitivity matching between cameras		
User data storage		
Programmable I/O		
Binning	*	*
Band ROI	*	*
√: standard -: Not available *: Available on request		

Dimensions



Adimec support

Adimec QUARTZ cameras are designed, optimized and calibrated for demanding inspection and metrology applications.

All models of the QUARTZ series are customizable to fit specific system outline, functionality or performance requirements.

Please contact us about your possibilities.

For maximum image quality, performance, and reliability in demanding applications - Choose Adimec

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LFL Q-21A230/CXP-PA rev.0.8 - Detailed information on request - Subject to change without notice - Actual products may differ from photos

Japan & Korea